Search Notes



App	lication	/Control	No.
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Applicant(s)/Patent under Reexamination

10/809,340

Examiner

YAMAKAWA ET AL.
Art Unit

CUONG H. NGUYEN

3661

SEARCHED					
Class	Subclass	Date	Examiner		
701	21,41	1/6/2007	CHN		
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INT	INTERFERENCE SEARCHED		
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SEARCH I (INCLUDING SEAR		EGY)
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WEST/DERWENT	1/6/20	07 CHN
Inventors'names search	1/6/200	07 CHN
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